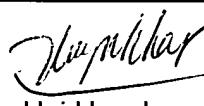


Issue Classification			Application/Control No.	Applicant(s)/Patent under Reexamination	
			10/631,832	HIRAMATSU ET AL.	
			Examiner	Art Unit	
			Hai H. Huynh	3747	

ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
123		634		123	635						
INTERNATIONAL CLASSIFICATION											
F	0	2	P	13/00							
				/							
				/							
				/							
				/							
(Assistant Examiner) (Date)				 Hai Huynh							
 8-12-05 (Legal Instruments Examiner) (Date)				Total Claims Allowed: 9 8-12-05 (Primary Examiner) (Date)							
								O.G. Print Claim(s)		O.G. Print Fig.	
								1		1	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	(1)		31		61		91
2	2		32		62		92
5	3		33		63		93
6	4		34		64		94
7	5		35		65		95
	6		36		66		96
8	7		37		67		97
3	8		38		68		98
4	9		39		69		99
9	(10)		40		70		100
11			41		71		101
12			42		72		102
13			43		73		103
14			44		74		104
15			45		75		105
16			46		76		106
17			47		77		107
18			48		78		108
19			49		79		109
20			50		80		110
21			51		81		111
22			52		82		112
23			53		83		113
24			54		84		114
25			55		85		115
26			56		86		116
27			57		87		117
28			58		88		118
29			59		89		119
30			60		90		120